Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination
10/541,307	ACKERMAN ET AL.
Examiner	Art Unit

1621

Jennifer Y. Cho

SEARCHED				
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search	3/29/2007	JC
STN Search	3/26/2007	RS
Inventor Search	3/27/2007	JC
560/217 - Text Search see Search History	3/29/2007	JC